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	Application No.	Applicant(s)
Notice of Allowability	10/077,036 Examiner	PARKER ET AL.  Art Unit
	Phillip A. Johnston	2881
The MAILING DATE of this communication appe All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT Re of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in this ap or other appropriate communicatior GHTS. This application is subject to	plication. If not included n will be mailed in due course. THIS
1. This communication is responsive to Appeal Brief filed 6-17-2005.		
2. X The allowed claim(s) is/are <u>70-109,111-127 and 129-147</u> .		
3. 🔀 The drawings filed on 15 February 2002 are accepted by the Examiner.		
4.		
Attachment(s)  1. ☐ Notice of References Cited (PTO-892)  2. ☐ Notice of Draftperson's Patent Drawing Review (PTO-948)  3. ☐ Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date  4. ☐ Examiner's Comment Regarding Requirement for Deposit of Biological Material	6. Interview Summary Paper No./Mail Da 8), 7. Examiner's Amend	te

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## Examiner's statement of reasons for allowance

The following is an examiner's statement of reasons for allowance:

- 1. Claims 70,89,105,129,145, and 147 are allowed because prior art fails to show a spectral processing method for compensating a plurality of sequential spectra and profiles derived therefrom for effects of drift of data along an independent variable axis, comprising: transforming a plurality of sequential spectra obtained from a spectrometer to provide an array of row vectors compensated for effects of drift of data along an independent variable axis, wherein the array of row vectors compensated for effects of drift of data along the independent variable axis constitutes a drift-compensated array; performing a principal-factor determination on the drift-compensated array to provide a set of principal factors compensated for effects of drift of data along the independent variable axis; and generating, from a profile trajectory of the row vectors compensated for effects of drift of data along the independent variable axis lying within a space of principal factors compensated for effects of drift of data along the independent variable axis, scaled target-factor profiles compensated for effects of drift of data along the independent variable axis, scaled target-factor profiles compensated for effects of drift of data along the independent variable axis.
- 2. Claims 71-88,90-104,106-109,11-127,130-144, and 146 are allowed by virtue of their dependency upon allowed claims 70,89,105,129,145, and 147.
- 3. The examiner agrees with Applicant's arguments presented in the appeal brief filed 6-17-2005, particularly that, Haaland's prediction curve generated from matrixed spectral shape data is not equivalent to applicants generated profile trajectory.

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Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

## Conclusion

4. Any inquiry concerning this communication or earlier communications should be directed to Phillip Johnston whose telephone number is (571) 272-2475. The examiner can normally be reached on Monday-Friday from 7:30 am to 4:00 pm. If attempts to reach the examiner by telephone are unsuccessful, the examiners supervisor John Lee can be reached at (571) 272-2477. The fax phone number for the organization where the application or proceeding is assigned is 703 872 9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

ΡJ

August 29, 2005

JOHN R. LEE

SUPERVISORY PATENT EXAMINER